

June 2010

FDMC7664

N-Channel PowerTrench $^{\! \rm I\!R}$ MOSFET 30 V, 18.8 A, 4.2 m Ω

Features

- Max $r_{DS(on)}$ = 4.2 m Ω at V_{GS} = 10 V, I_D = 18.8 A
- Max $r_{DS(on)}$ = 5.5 m Ω at V_{GS} = 4.5 V, I_D = 16.1 A
- High performance technology for extremely low r_{DS(on)}
- Termination is Lead-free and RoHS Compliant

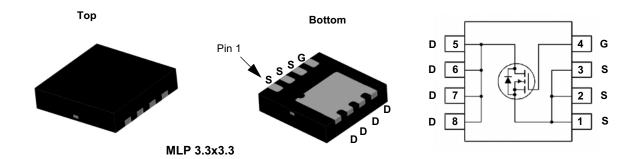


General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench® process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

Applications

- DC DC Buck Converters
- Notebook battery power management
- Load switch in Notebook



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

| Symbol | Parameter | Parameter | | | |
|-----------------------------------|-----------------------------------------------|--------------------------------------------------|-----------|------|------|
| V _{DS} | Drain to Source Voltage | 30 | V | | |
| V_{GS} | Gate to Source Voltage | | | ±20 | V |
| | Drain Current -Continuous (Package limited) | T _C = 25 °C | | 24 | |
| I _D | -Continuous | T _A = 25 °C | (Note 1a) | 18.8 | Α |
| | -Pulsed | | | 60 | |
| E _{AS} | Single Pulse Avalanche Energy | | (Note 3) | 188 | mJ |
| Б | Power Dissipation | T _C = 25 °C | | 42 | w |
| P _D | Power Dissipation | T _A = 25 °C | (Note 1a) | 2.3 | _ vv |
| T _J , T _{STG} | Operating and Storage Junction Temperature Ra | Operating and Storage Junction Temperature Range | | | °C |

Thermal Characteristics

| $R_{	heta JC}$ | Thermal Resistance, Junction to Case | 3.0 | °C/W |
|-----------------|-------------------------------------------------|-------|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient (Note 1 | a) 53 | C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|----------|-------------|-----------|------------|------------|
| FDMC7664 | FDMC7664 | MLP 3.3x3.3 | 13 " | 12 mm | 3000 units |

Electrical Characteristics T_J = 25 °C unless otherwise noted

| Symbol | Parameter | eter Test Conditions | | Тур | Max | Units |
|----------------------------------------|----------------------------------------------|------------------------------------------------------------------------|----|-----|----------|-------|
| Off Chara | cteristics | | | | | |
| BV_{DSS} | Drain to Source Breakdown Voltage | I _D = 250 μA, V _{GS} = 0 V | 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I_D = 250 μA, referenced to 25 °C | | 12 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$ $T_{J} = 125 \text{ °C}$ | | | 1 250 | μА |
| I _{GSS} | Gate to Source Leakage Current, Forward | V _{GS} = 20 V, V _{DS} = 0 V | | | 100 | nA |

On Characteristics

| V _{GS(th)} | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_{D} = 250 \mu A$ | 1.0 | 1.9 | 3.0 | ٧ |
|----------------------------------------|----------------------------------------------------------|----------------------------------------------------------------------------|-----|-----|-----|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I _D = 250 μA, referenced to 25 °C | | -7 | | mV/°C |
| | Static Drain to Source On Resistance | V _{GS} = 10 V, I _D = 18.8 A | | 3.6 | 4.2 | mΩ |
| race | | V _{GS} = 4.5 V, I _D = 16.1 A | | 4.5 | 5.5 | |
| r _{DS(on)} | | V _{GS} = 10 V, I _D = 18.8 A T _J = 125 °C | | 4.4 | 5.4 | 11132 |
| 9 _{FS} | Forward Transconductance | V _{DD} = 5 V, I _D = 18.8 A | | 115 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V -45 V V - 0 V | 3655 | 4865 | pF |
|------------------|------------------------------|--------------------------------------------------------------|------|------|----|
| C _{oss} | Output Capacitance | V _{DS} = 15 V, V _{GS} = 0 V ——f = 1 MHz | 1100 | 1465 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1 1011 12 | 115 | 170 | pF |
| R _a | Gate Resistance | | 0.8 | 2.2 | Ω |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | | 15 | 27 | ns |
|---------------------|-------------------------------|-------------------------------------------------------|----|----|----|
| t _r | Rise Time | V _{DD} = 15 V, I _D = 18.8 A | 7 | 14 | ns |
| t _{d(off)} | Turn-Off Delay Time | V_{GS} = 10 V, R_{GEN} = 6 Ω | 37 | 59 | ns |
| t _f | Fall Time | | 6 | 12 | ns |
| $Q_{g(TOT)}$ | Total Gate Charge | V _{GS} = 0 V to 10 V | 55 | 76 | nC |
| Qg | Total Gate Charge | V _{GS} = 0 V to 4.5 V V _{DD} = 15 V | 25 | 34 | nC |
| Q _{gs} | Gate to Source Charge | I _D = 18.8 A | 12 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | 6 | | nC |

Drain-Source Diode Characteristics

| V _{SD} | Source to Drain Dioge Forward Voltage | $V_{GS} = 0 \text{ V}, I_S = 18.8 \text{ A}$ (Note 2) | | 0.83 | 1.2 | \/ |
|-----------------|---------------------------------------|--------------------------------------------------------|--|------|-----|----------|
| | | V _{GS} = 0 V, I _S = 1.9 A (Note 2) | | 0.71 | 1.2 | ' |
| t _{rr} | Reverse Recovery Time | L = 19.9 A di/dt = 100 A/ | | 41 | 65 | ns |
| Q _{rr} | Reverse Recovery Charge | I _F = 18.8 A, di/dt = 100 A/μs | | 20 | 35 | nC |

NOTES:

1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



a. 53 °C/W when mounted on a 1 in² pad of 2 oz copper



b.125 °C/W when mounted on a minimum pad of 2 oz copper

^{2.} Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0 %.

^{3.} E $_{AS}$ of 188 mJ is based on starting T $_{J}$ = 25 °C, L = 1 mH, I $_{AS}$ = 19.4 A, V $_{DD}$ = 27 V, V $_{GS}$ = 10 V.

Typical Characteristics T_J = 25 °C unless otherwise noted

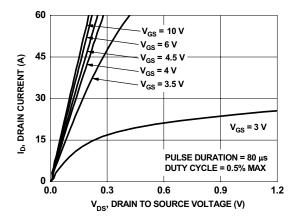


Figure 1. On Region Characteristics

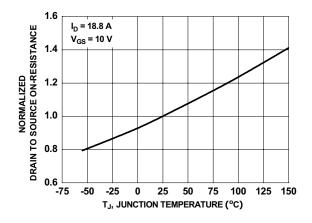


Figure 3. Normalized On Resistance vs Junction Temperature

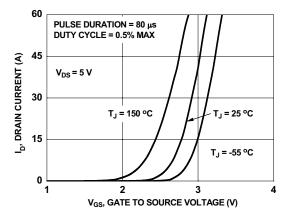


Figure 5. Transfer Characteristics

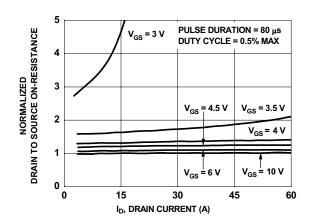


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

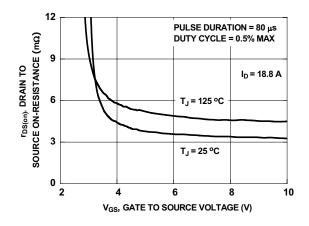


Figure 4. On-Resistance vs Gate to Source Voltage

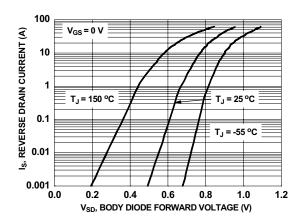


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

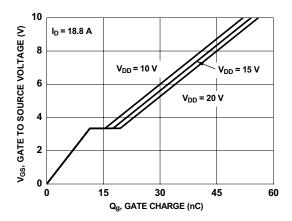


Figure 7. Gate Charge Characteristics

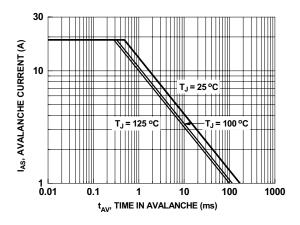


Figure 9. Unclamped Inductive Switching Capability

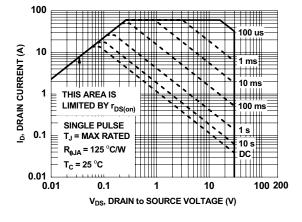


Figure 11. Forward Bias Safe Operating Area

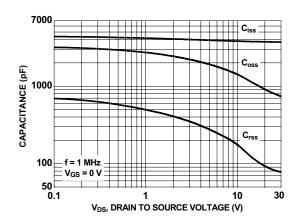


Figure 8. Capacitance vs Drain to Source Voltage

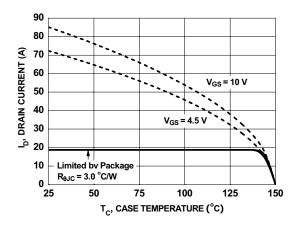


Figure 10. Maximum Continuous Drain Current vs Case Temperature

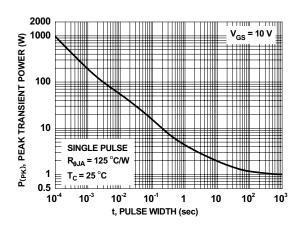


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25 °C unless otherwise noted

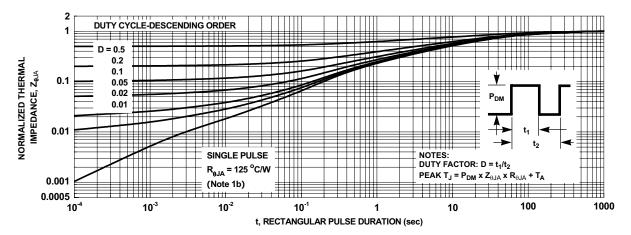
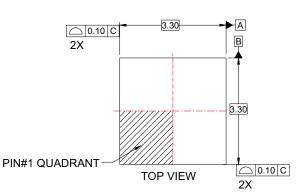
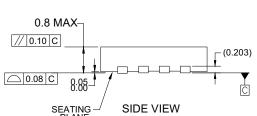
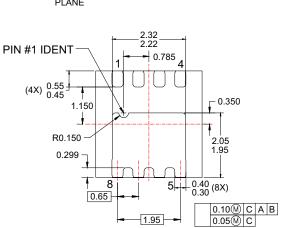


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout





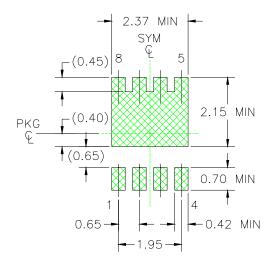


BOTTOM VIEW

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NOTES:

- A. DOES NOT CONFORM TO JEDEC **REGISTRATION MO-229**
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- D. DRAWING FILE NAME: MLP08SREVA
- E. LAND PATTERN RECOMMENDATION IS BASED ON FSC DESIGN ONLY



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